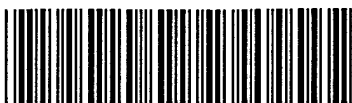


Search Notes

Application/Control No.

10/501,124

Examiner

Matthew L. Fedowitz

Applicant(s)/Patent under
Reexamination

UZAWA ET AL.

Art Unit

1623

SEARCHED

Class	Subclass	Date	Examiner
514	25	5/23/2005	MLF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search	5/23/2005	MLF
PALM Inventor search	5/23/2005	MLF